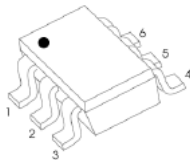
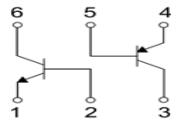


FEATURES

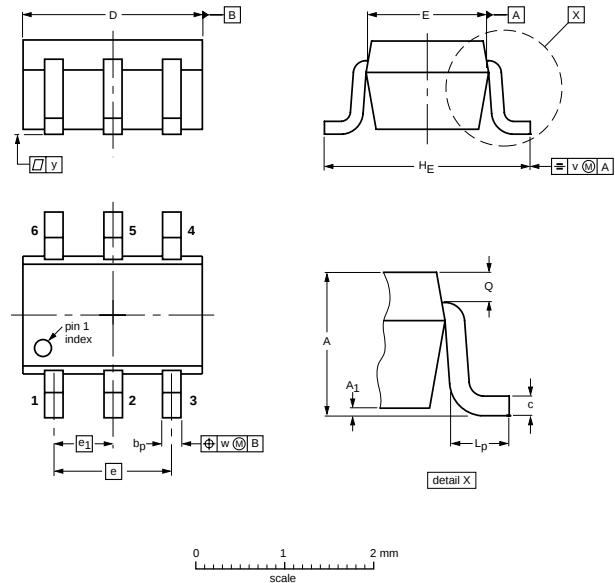
Epitaxial Die Construction
Two isolated NPN/PNP(BC846W+BC856W) Transistors in one package



SOT-363



SOT-363



DIMENSIONS (mm are the original dimensions)

UNIT	A	A1 max	bp	c	D	E	e	e1	HE	Lp	Q	v	w	y
mm	1.1 0.8	0.1	0.30 0.20	0.25 0.10	2.2 1.8	1.35 1.15	1.3	0.65	2.2 2.0	0.45 0.15	0.25 0.15	0.2	0.2	0.1

MAXIMUM RATINGS TR1 (T_a=25°C unless otherwise noted)

Symbol	Parameter	Value	Units
V _{CBO}	Collector-Base Voltage	80	V
V _{CEO}	Collector-Emitter Voltage	65	V
V _{EBO}	Emitter-Base Voltage	6	V
I _C	Collector Current –Continuous	0.1	A
P _C	Collector Power Dissipation	200	mW
T _J	Junction Temperature	150	°C
T _{stg}	Storage Temperature	-55-150	°C

BC846BPN

CHARACTERISTICS of TR1 (NPN Transistor) (Ta=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Typ	Max	Unit
Collector-base breakdown voltage	$V_{(BR)CBO}$	$I_C=10\mu A, I_E=0$	80			V
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C=10mA, I_B=0$	65			V
Emitter-base breakdown voltage	$V_{(BR)EBO}$	$I_E=1\mu A, I_C=0$	6			V
Collector cut-off current	I_{CBO}	$V_{CB}=30V, I_E=0$			15	nA
Emitter cut-off current	I_{EBO}	$V_{EB}=5V, I_C=0$			15	nA
DC current gain	h_{FE}	$V_{CE}=5V, I_C=2mA$	200		475	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.25	V
	$V_{CE(sat)}$	$I_C=100mA, I_B=5mA$			0.6	V
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C=10mA, I_B=0.5mA$		0.7		V
	$V_{BE(sat)}$	$I_C=100mA, I_B=5mA$		0.9		V
Base-emitter voltage	$V_{BE(on)}$	$V_{CE}=5V, I_C=2mA$	0.58		0.7	V
	$V_{BE(on)}$	$V_{CE}=5V, I_C=10mA$			0.72	V
Collector output capacitance	C_{ob}	$V_{CB}=10V, I_E=0, f=1MHz$			4.5	pF
Transition frequency	f_T	$V_{CE}=5V, I_C=10mA, f=100MHz$	100			MHz
Noise figure	NF	$V_{CE}=5V, I_C=0.2mA, f=1kHz, R_g=2K\Omega, \Delta f=200Hz$			10	dB

BC846BPN

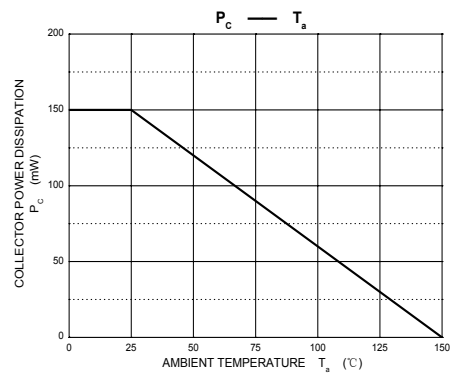
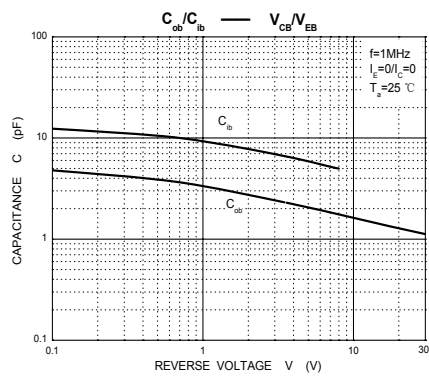
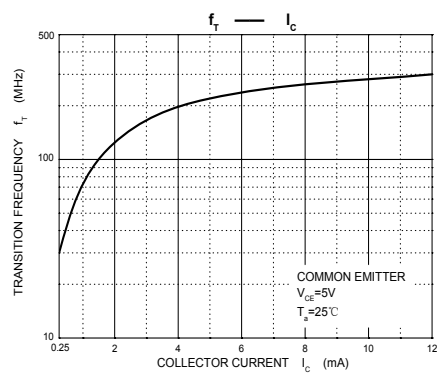
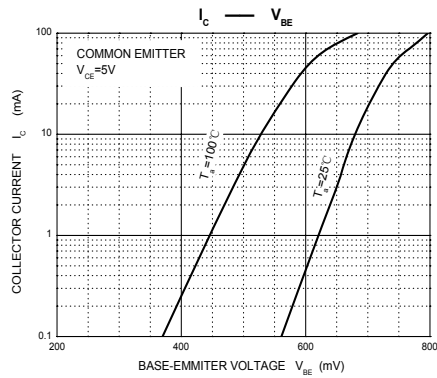
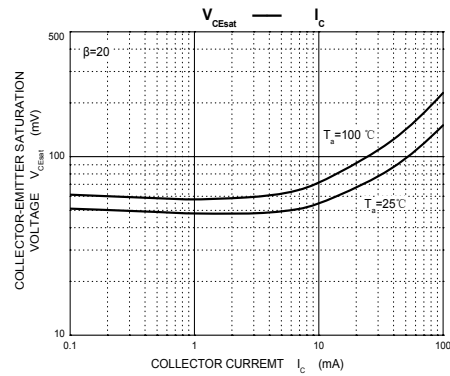
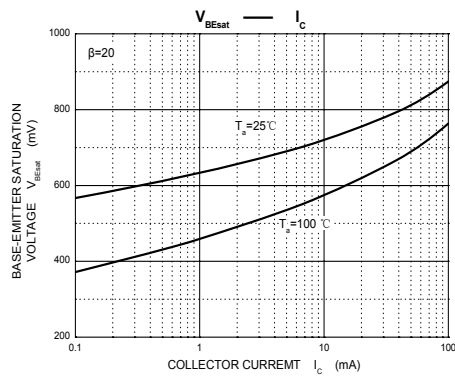
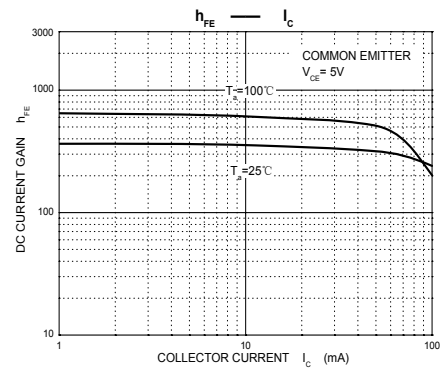
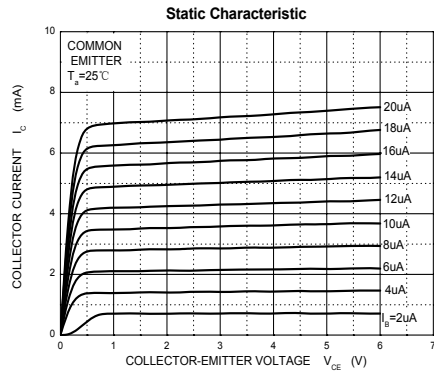
MAXIMUM RATINGS TR2 ($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Units
V_{CBO}	Collector-Base Voltage	-80	V
V_{CEO}	Collector-Emitter Voltage	-65	V
V_{EBO}	Emitter-Base Voltage	-5	V
I_C	Collector Current –Continuous	-0.1	A
P_{C^*}	Collector Power Dissipation	200	mW
T_J	Junction Temperature	150	$^{\circ}\text{C}$
T_{stg}	Storage Temperature	-55-150	$^{\circ}\text{C}$

CHARACTERISTICS of TR2 (PNP Transistor) ($T_a=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Collector-base breakdown voltage	$V_{(BR)CBO}$	$I_C=-10\mu\text{A}, I_E=0$	-80			V
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C=-10\text{mA}, I_B=0$	-65			V
Emitter-base breakdown voltage	$V_{(BR)EBO}$	$I_E=-1\mu\text{A}, I_C=0$	-5			V
Collector cut-off current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$			-15	nA
Emitter cut-off current	I_{EBO}	$V_{EB}=-5\text{V}, I_C=0$			-15	nA
DC current gain	h_{FE1}	$V_{CE}=-5\text{V}, I_C=-2\text{mA}$	200		475	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
	$V_{CE(sat)}$	$I_C=-100\text{mA}, I_B=-5\text{mA}$			-0.65	V
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		-0.7		V
	$V_{BE(sat)}$	$I_C=-100\text{mA}, I_B=-5\text{mA}$			-0.95	V
Base-emitter voltage	$V_{BE(on)}$	$V_{CE}=-5\text{V}, I_C=-2\text{mA}$	-0.6		-0.75	V
	$V_{BE(on)}$	$V_{CE}=-5\text{V}, I_C=-10\text{mA}$			-0.82	V
Collector output capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0, f=1\text{MHz}$			4.5	pF
Transition frequency	f_T	$V_{CE}=-5\text{V}, I_C=-10\text{mA}, f=100\text{MHz}$	100			MHz
Noise figure	NF	$V_{CE}=-5\text{V}, I_C=-0.2\text{mA}, f=1\text{kHz}, R_g=2\text{k}\Omega, \Delta f=200\text{Hz}$			10	dB

RATING AND CHARACTERISTIC CURVES (BC846BPN)



RATING AND CHARACTERISTIC CURVES (BC846BPN)

